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# HAT3008R/HAT3008RJ

Silicon N/P Channel Power MOS FET  
High Speed Power Switching

## HITACHI

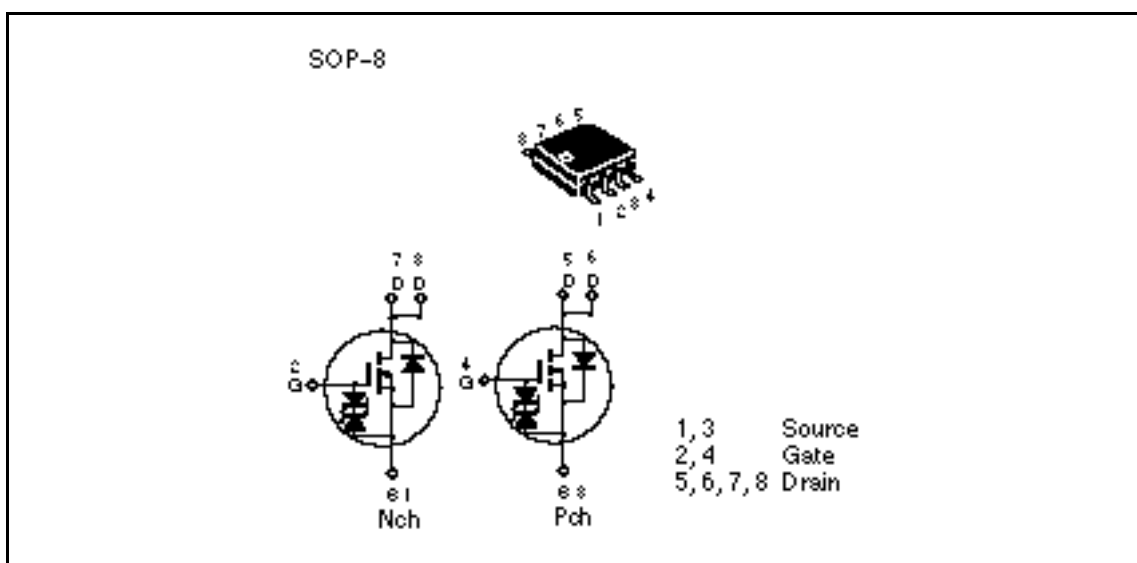
ADE-208-536B (Z)  
3rd. Edition  
February 1999

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### Features

- For Automotive Application ( at Type Code "J " )
- Low on-resistance
- Capable of 4 V gate drive
- High density mounting

### Outline



## HAT3008R/HAT3008RJ

### Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings		Unit
		Nch	Pch	
Drain to source voltage	$V_{DSS}$	60	-60	V
Gate to source voltage	$V_{GSS}$	±20	±20	V
Drain current	$I_D$	5	-3.5	A
Drain peak current	$I_{D(pulse)}$ <sup>Note1</sup>	40	-28	A
Body-drain diode reverse drain current	$I_{DR}$	5	-3.5	A
Avalanche current	HAT3008R	$I_{AP}$ <sup>Note4</sup>	—	—
	HAT3008RJ	5	-3.5	A
Avalanche energy	HAT3008R	$E_{AR}$ <sup>Note4</sup>	—	—
	HAT3008RJ	2.14	1.05	mJ
Channel dissipation	$P_{ch}$ <sup>Note2</sup>	2	2	W
Channel dissipation	$P_{ch}$ <sup>Note3</sup>	3	3	W
Channel temperature	$T_{ch}$	150	150	°C
Storage temperature	$T_{stg}$	-55 to +150	-55 to +150	°C

Note: 1. PW 10μs, duty cycle 1 %

2. 1 Drive operation ; When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW 10s

3. 2 Drive operation ; When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW 10s

4. Value at T<sub>ch</sub>=25°C, R<sub>g</sub> 50

## HAT3008R/HAT3008RJ

### Electrical Characteristics (Ta = 25°C)

#### • N Channel

Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	60	—	—	V	$I_D = 10mA, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±20	—	—	V	$I_G = \pm 100\mu A, V_{DS} = 0$
Gate to source leak current	$I_{GSS}$	—	—	±10	μA	$V_{GS} = \pm 16V, V_{DS} = 0$
Zero gate voltage drain current	HAT3008R $I_{DSS}$	—	—	1	μA	$V_{DS} = 60V, V_{GS} = 0$
	HAT3008RJ $I_{DSS}$	—	—	0.1	μA	
Zero gate voltage drain current	HAT3008R $I_{DSS}$	—	—	—	μA	$V_{DS} = 48V, V_{GS} = 0$
	HAT3008RJ $I_{DSS}$	—	—	10	μA	$T_a = 125^\circ C$
Gate to source cutoff voltage	$V_{GS(off)}$	1.2	—	2.2	V	$V_{DS} = 10V, I_D = 1mA$
Static drain to source on state resistance	$R_{DS(on)}$	—	0.043	0.058		$I_D = 3A, V_{GS} = 10V$ <sup>Note4</sup>
	$R_{DS(on)}$	—	0.056	0.084		$I_D = 3A, V_{GS} = 4V$ <sup>Note4</sup>
Forward transfer admittance	$ y_{fs} $	6	9	—	S	$I_D = 3A, V_{DS} = 10V$ <sup>Note4</sup>
Input capacitance	$C_{iss}$	—	520	—	pF	$V_{DS} = 10V$
Output capacitance	$C_{oss}$	—	270	—	pF	$V_{GS} = 0$
Reverse transfer capacitance	$C_{rss}$	—	100	—	pF	$f = 1MHz$
Turn-on delay time	$t_{d(on)}$	—	11	—	ns	$V_{GS} = 10V, I_D = 3A$
Rise time	$t_r$	—	40	—	ns	$V_{DD} = 30V$
Turn-off delay time	$t_{d(off)}$	—	110	—	ns	
Fall time	$t_f$	—	80	—	ns	
Body-drain diode forward voltage	$V_{DF}$	—	0.84	1.1	V	$I_F = 5A, V_{GS} = 0$ <sup>Note4</sup>
Body-drain diode reverse recovery time	$t_{rr}$	—	40	—	ns	$I_F = 5A, V_{GS} = 0$ $diF/dt = 50A/\mu s$

Note: 5. Pulse test

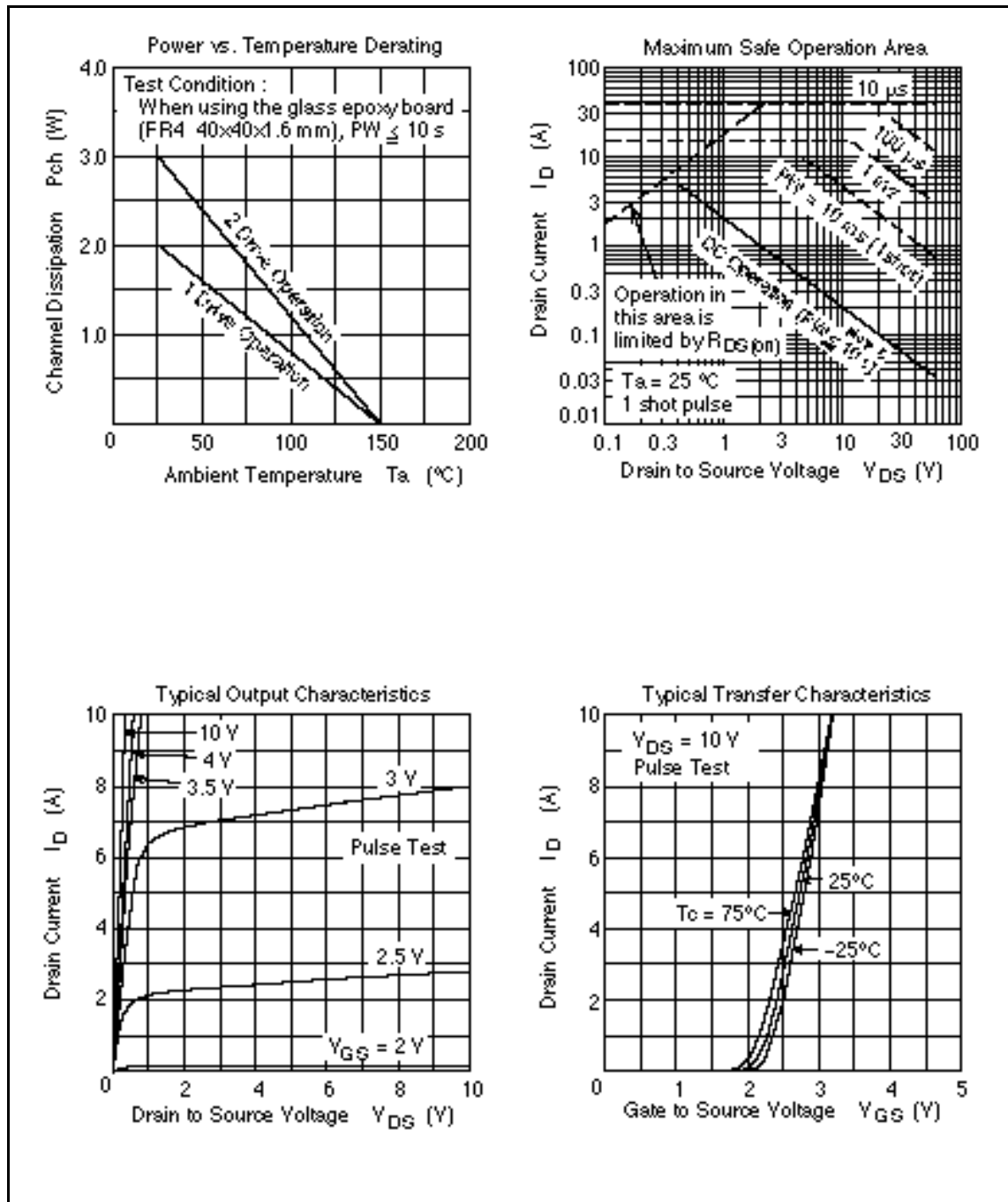
## HAT3008R/HAT3008RJ

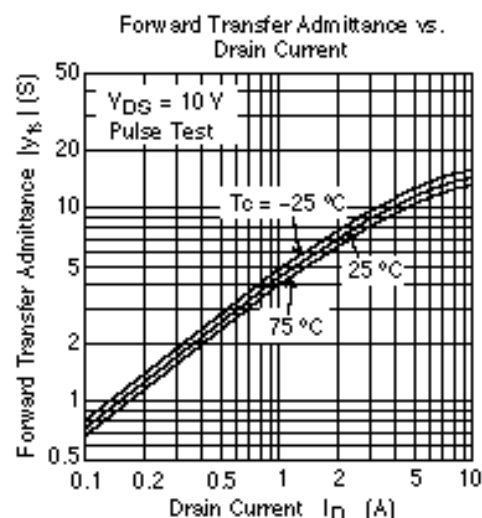
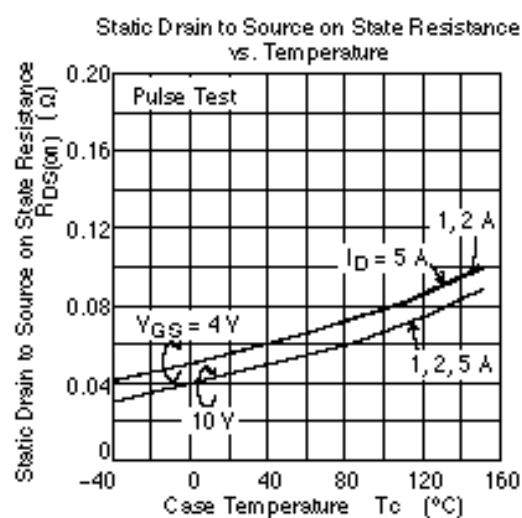
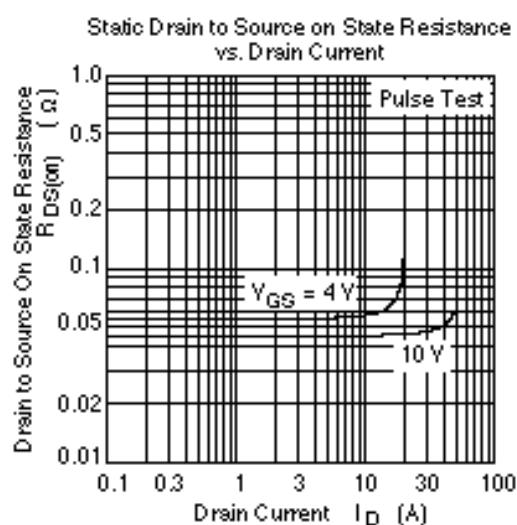
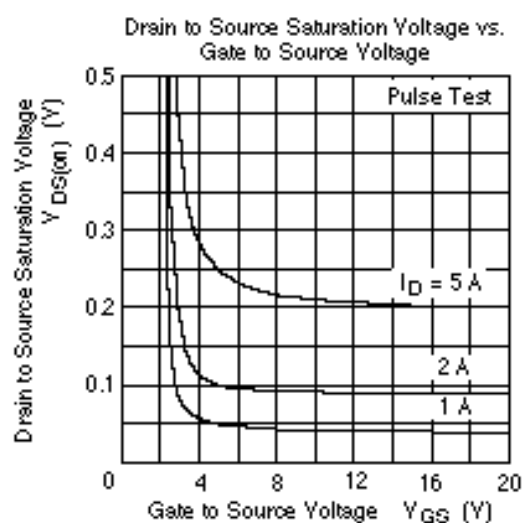
### • P Channel

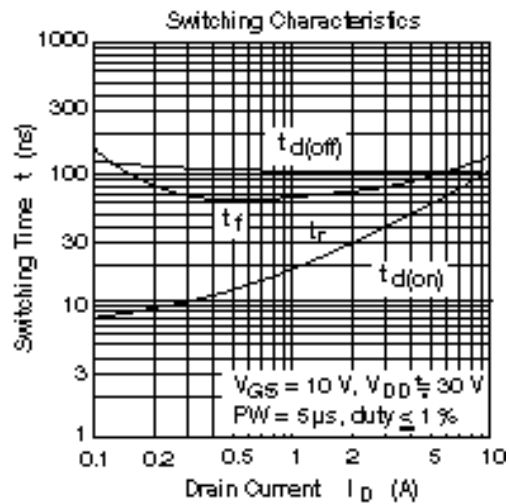
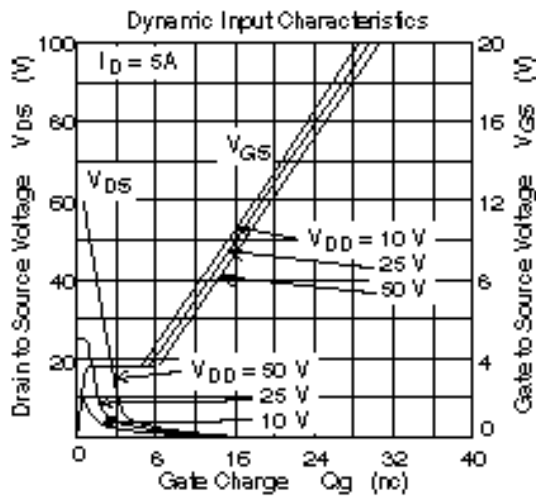
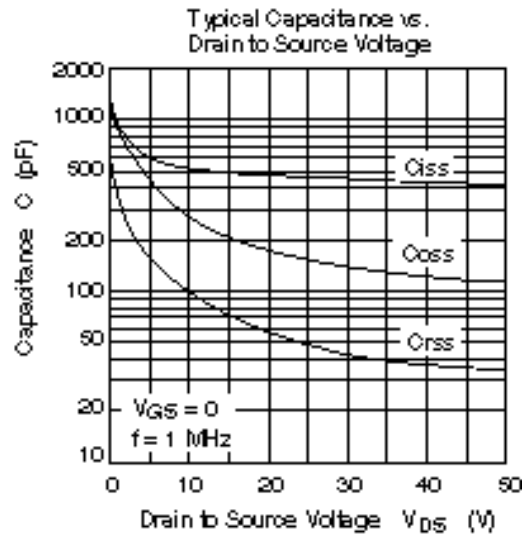
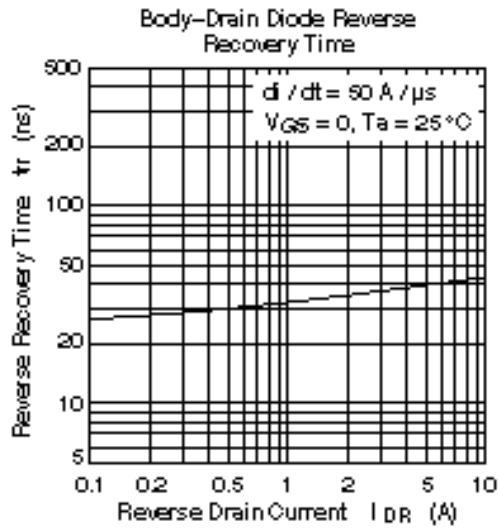
Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	-60	—	—	V	$I_D = -10\text{mA}$ , $V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	$\pm 20$	—	—	V	$I_G = \pm 100\mu\text{A}$ , $V_{DS} = 0$
Gate to source leak current	$I_{GSS}$	—	—	$\pm 10$	$\mu\text{A}$	$V_{GS} = \pm 16\text{V}$ , $V_{DS} = 0$
Zero gate voltage	HAT3008R	$I_{DSS}$	—	-1	$\mu\text{A}$	$V_{DS} = -60\text{V}$ , $V_{GS} = 0$
drain current	HAT3008RJ	$I_{DSS}$	—	-0.1	$\mu\text{A}$	
Zero gate voltage	HAT3008R	$I_{DSS}$	—	—	$\mu\text{A}$	$V_{DS} = -48\text{V}$ , $V_{GS} = 0$
drain current	HAT3008RJ	$I_{DSS}$	—	-10	$\mu\text{A}$	$T_a = 125^\circ\text{C}$
Gate to source cutoff voltage	$V_{GS(off)}$	-1.2	—	-2.2	V	$V_{DS} = -10\text{V}$ , $I_D = -1\text{mA}$
Static drain to source on state	$R_{DS(on)}$	—	0.12	0.15		$I_D = -2\text{A}$ , $V_{GS} = -10\text{V}$ <sup>Note4</sup>
resistance	$R_{DS(on)}$	—	0.16	0.23		$I_D = -2\text{A}$ , $V_{GS} = -4\text{V}$ <sup>Note4</sup>
Forward transfer admittance	$ y_{fs} $	3	4.5	—	S	$I_D = -2\text{A}$ , $V_{DS} = -10\text{V}$ <sup>Note4</sup>
Input capacitance	$C_{iss}$	—	600	—	pF	$V_{DS} = -10\text{V}$
Output capacitance	$C_{oss}$	—	290	—	pF	$V_{GS} = 0$
Reverse transfer capacitance	$C_{rss}$	—	75	—	pF	$f = 1\text{MHz}$
Turn-on delay time	$t_{d(on)}$	—	11	—	ns	$V_{GS} = -10\text{V}$ , $I_D = -2\text{A}$
Rise time	$t_r$	—	30	—	ns	$V_{DD} = -30\text{V}$
Turn-off delay time	$t_{d(off)}$	—	100	—	ns	
Fall time	$t_f$	—	55	—	ns	
Body-drain diode forward voltage	$V_{DF}$	—	-0.98	-1.28	V	$I_F = -3.5\text{A}$ , $V_{GS} = 0$ <sup>Note4</sup>
Body-drain diode reverse recovery time	$t_{rr}$	—	70	—	ns	$I_F = -3.5\text{A}$ , $V_{GS} = 0$ $diF/dt = 50\text{A}/\mu\text{s}$

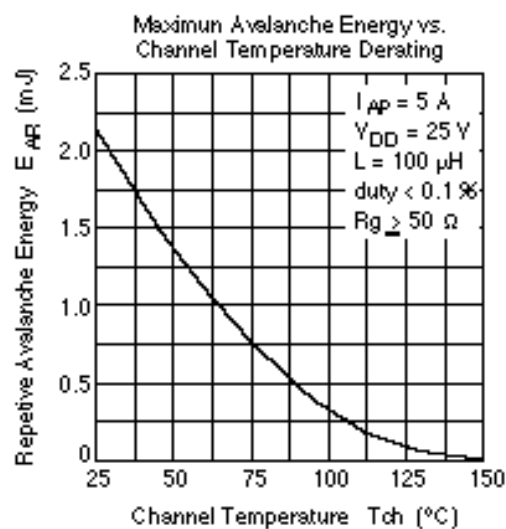
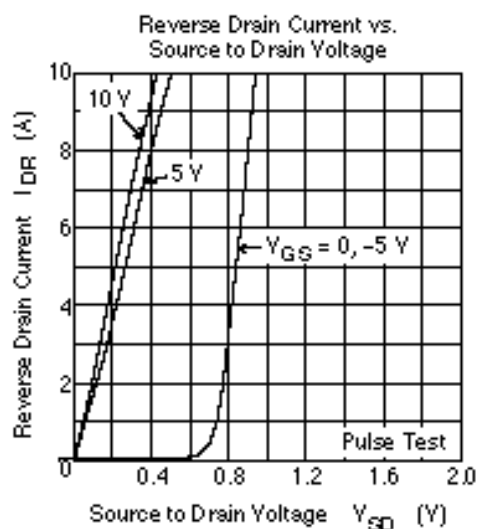
Note: 5. Pulse test

# Main Characteristics ( N Channel )

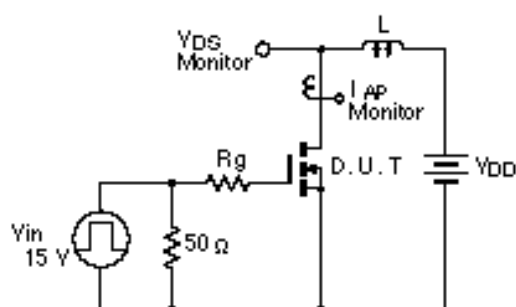






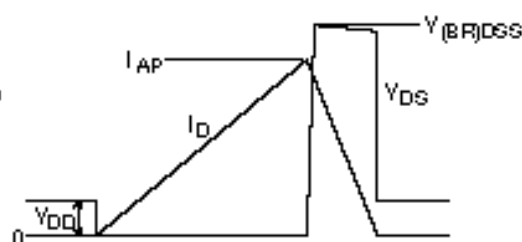


Avalanche Test Circuit

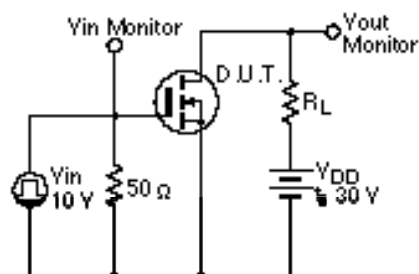


Avalanche Waveform

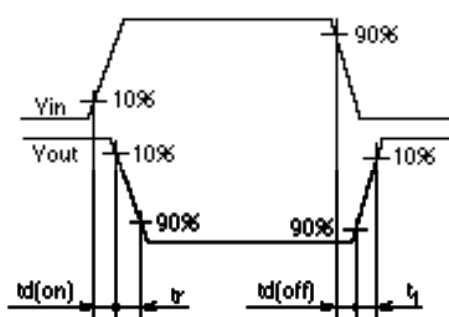
$$E_{AR} = \frac{1}{2} \cdot L \cdot I_{AP}^2 \cdot \frac{V_{DSS}}{V_{DSS} - V_{DD}}$$



Switching Time Test Circuit

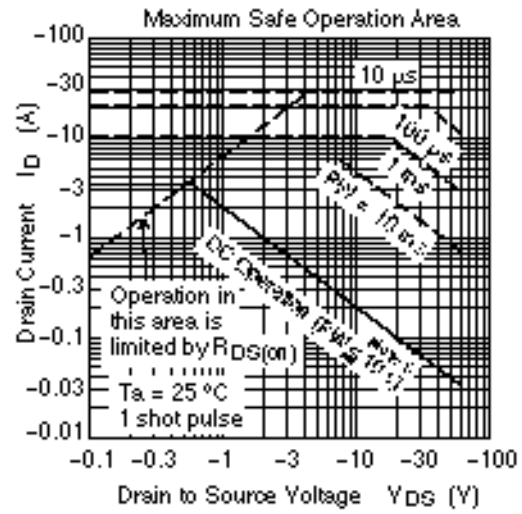
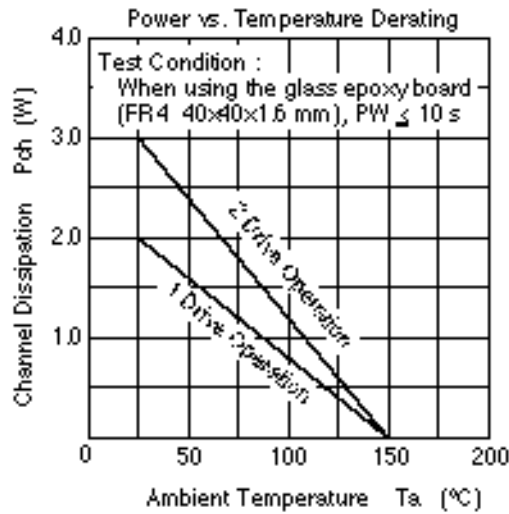


Switching Time Waveform

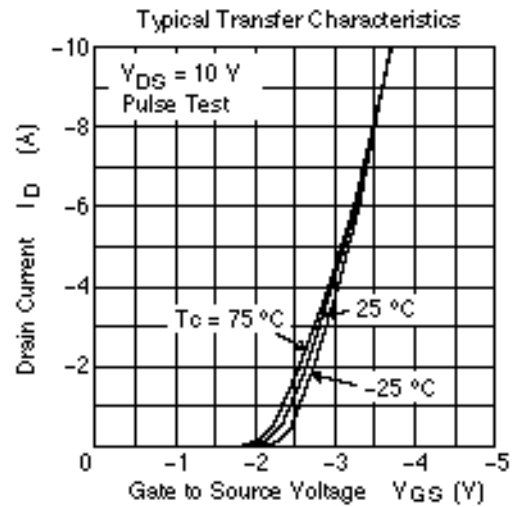
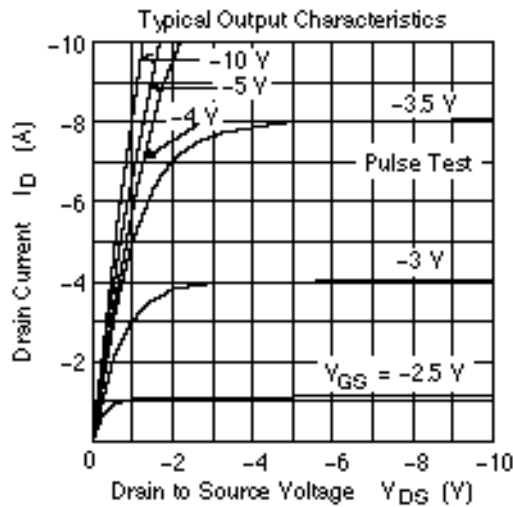


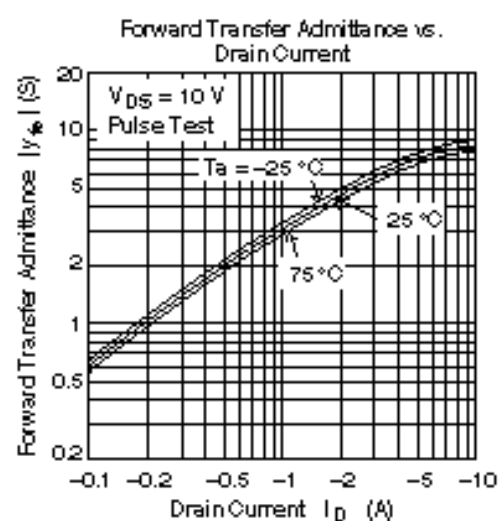
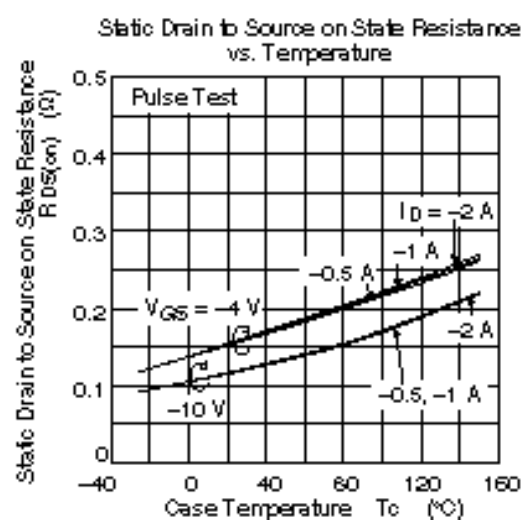
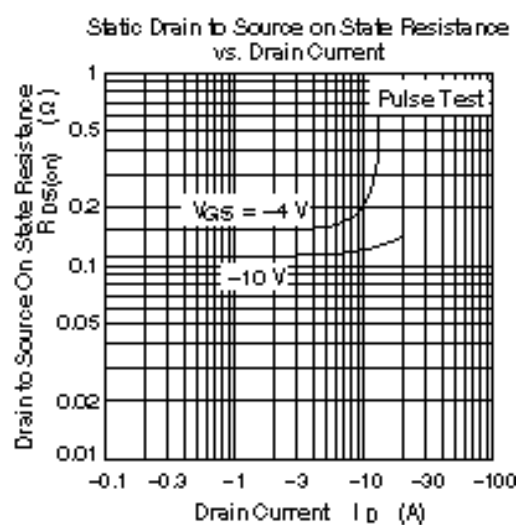
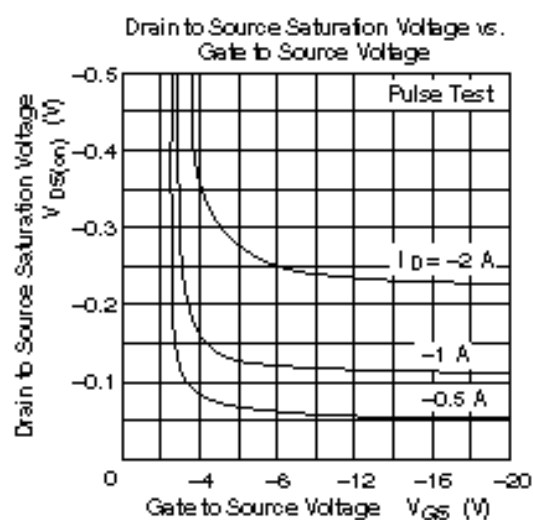
## Main Characteristics ( P Channel )

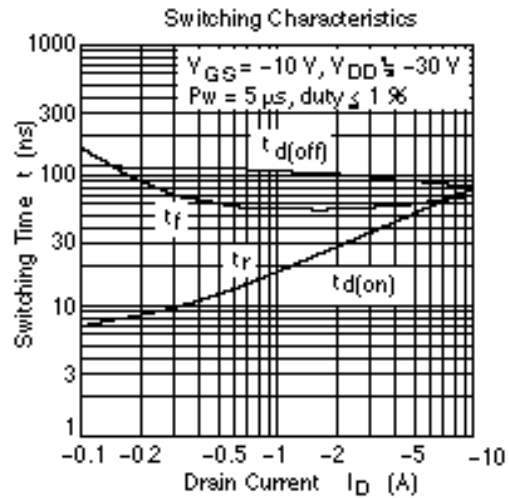
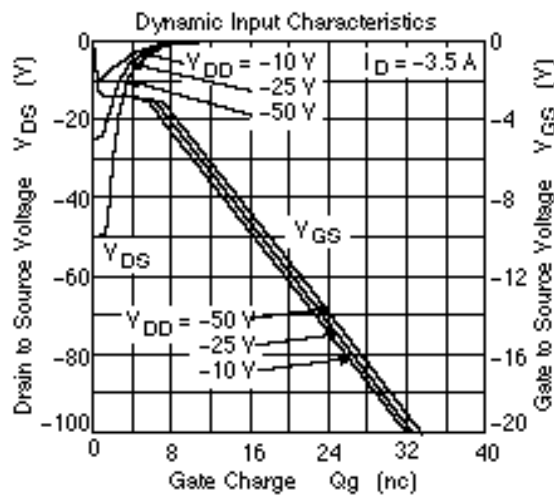
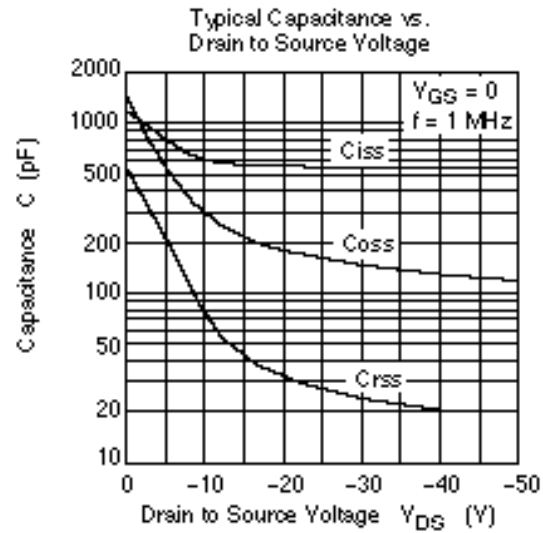
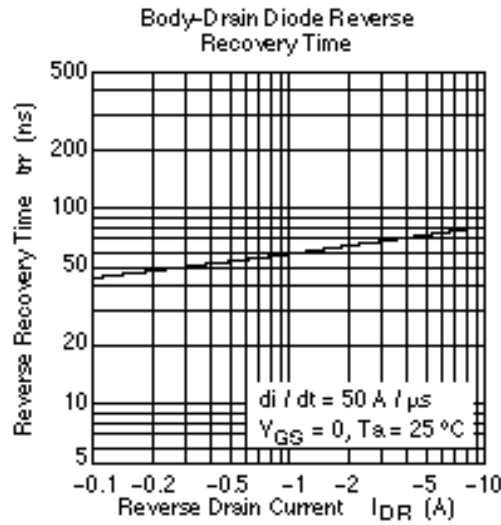


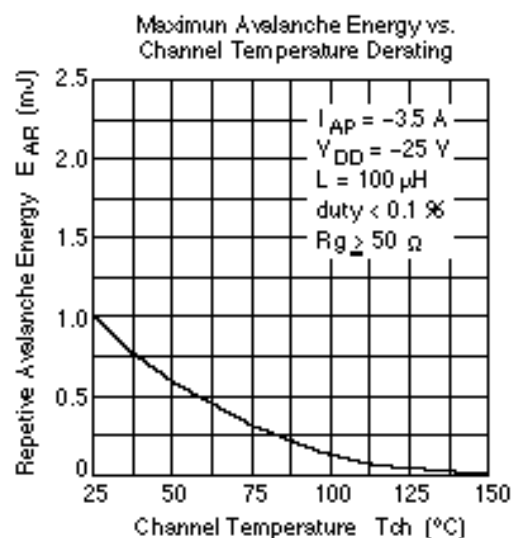
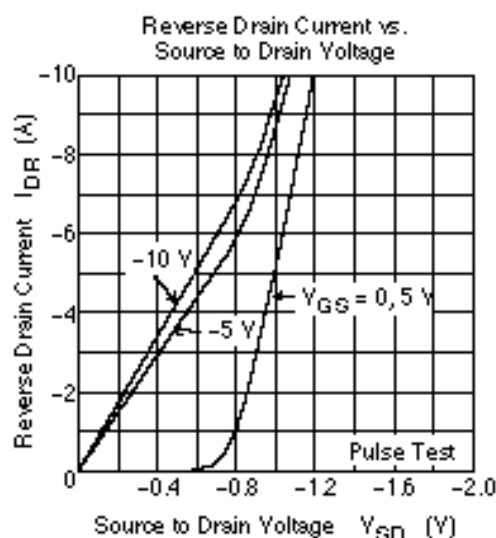


Note 6 :  
When using the glass epoxy board  
(FR4 40×40×1.6 mm)

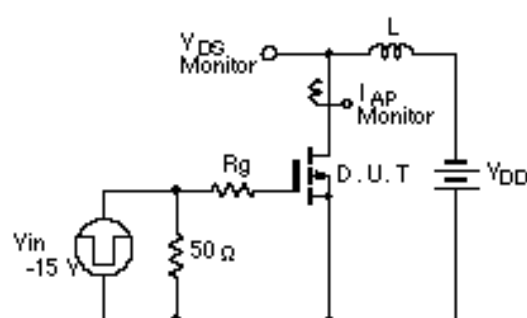






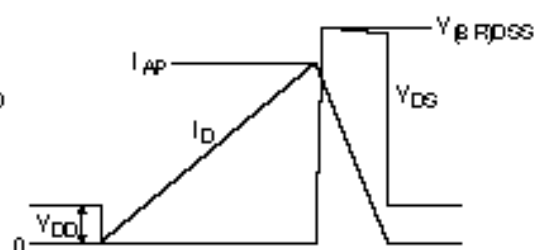


Avalanche Test Circuit

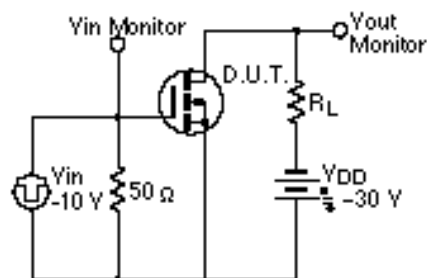


Avalanche Waveform

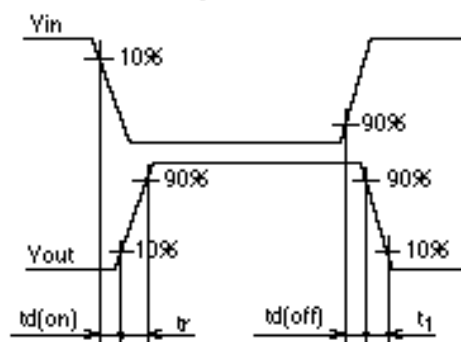
$$E_{AR} = \frac{1}{2} \cdot L \cdot I_{AP}^2 \cdot \frac{V_{DSS}}{V_{DSS} - V_{DD}}$$

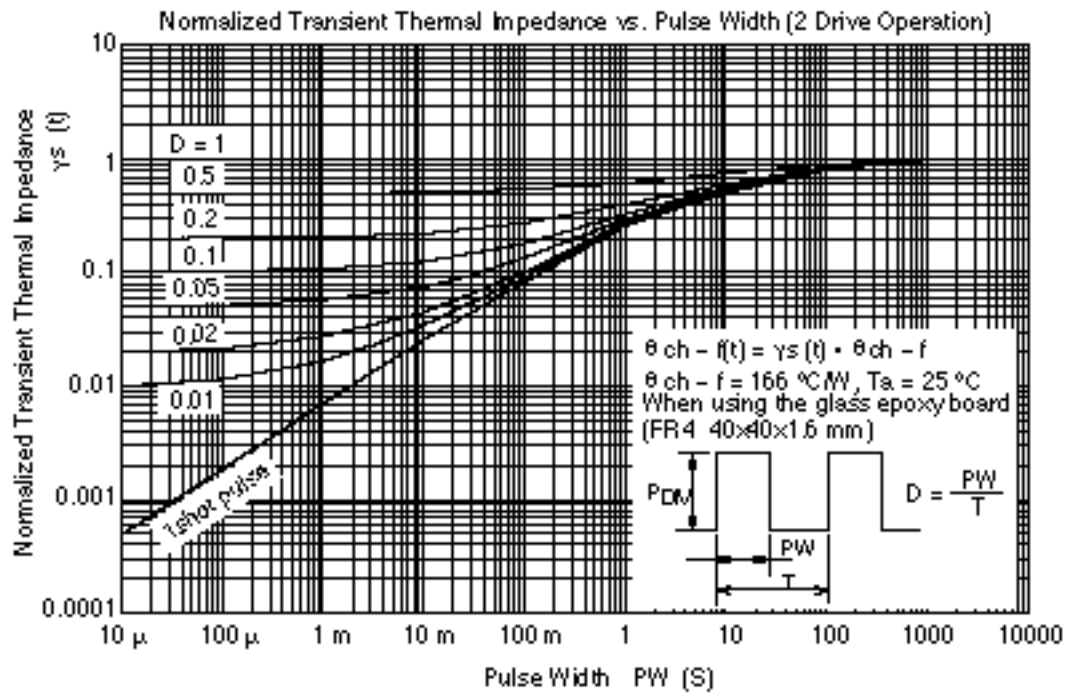
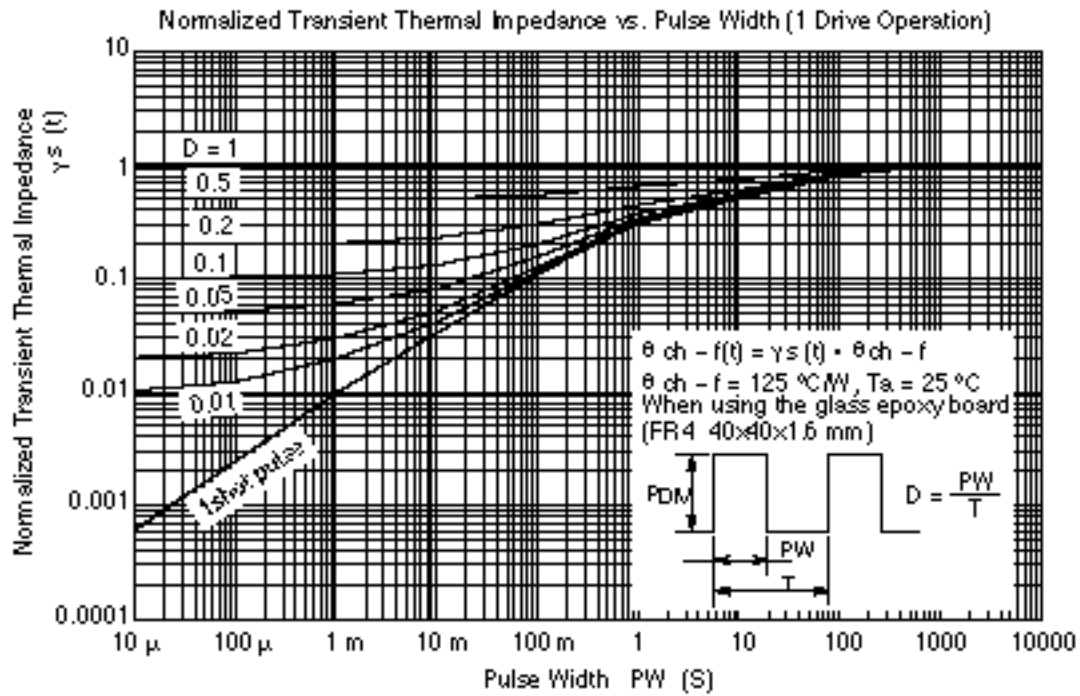


Switching Time Test Circuit



Switching Time Waveform

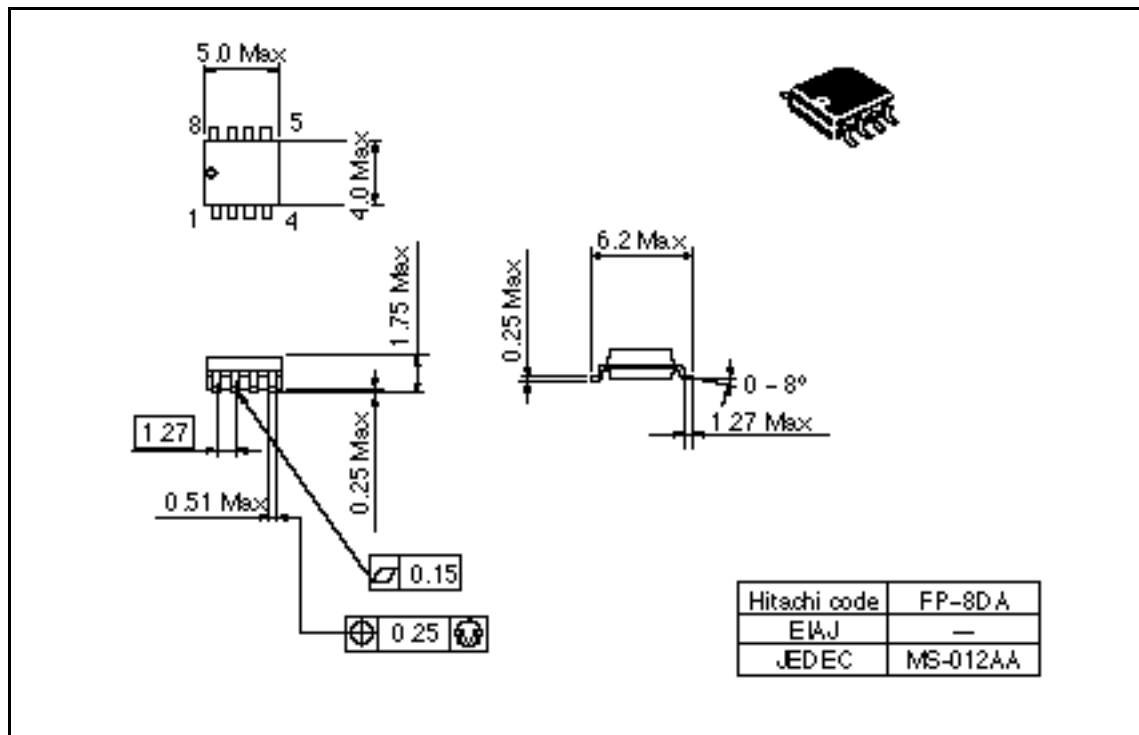




## HAT3008R/HAT3008RJ

### Package Dimensions

Unit: mm



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